

N-Channel Power MOSFET

30V, 5.5A, 32mΩ

FEATURES

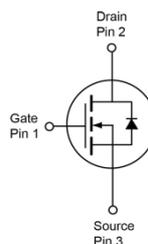
- Low $R_{DS(on)}$ to minimize conductive losses
- Low gate charge for fast power switching
- Compliant to RoHS directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

KEY PERFORMANCE PARAMETERS

PARAMETER	VALUE	UNIT
V_{DS}	30	V
$R_{DS(on)}$ (max)	$V_{GS} = 4.5V$	32
	$V_{GS} = 2.5V$	40
Q_g	8.9	nC

APPLICATIONS

- Battery Power Management
- ORing FET/Load Switch



Note: MSL 1 (Moisture Sensitivity Level) per J-STD-020

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ^(Note 1)	$T_C = 25^\circ\text{C}$	5.5	A
	$T_A = 25^\circ\text{C}$	4	
Pulsed Drain Current	I_{DM}	22	A
Total Power Dissipation	$T_C = 25^\circ\text{C}$	1.8	W
	$T_C = 125^\circ\text{C}$	0.4	
Total Power Dissipation	$T_A = 25^\circ\text{C}$	1	W
	$T_A = 125^\circ\text{C}$	0.2	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	- 55 to +150	$^\circ\text{C}$

THERMAL PERFORMANCE

PARAMETER	SYMBOL	LIMIT	UNIT
Junction to Case Thermal Resistance	$R_{\theta JC}$	70	$^\circ\text{C/W}$
Junction to Ambient Thermal Resistance	$R_{\theta JA}$	124	$^\circ\text{C/W}$

Thermal Performance Note: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\theta JA}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

ELECTRICAL SPECIFICATIONS ($T_A = 25^\circ\text{C}$ unless otherwise noted)						
PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	BV_{DSS}	30	--	--	V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	$V_{GS(TH)}$	0.4	0.75	0.9	V
Gate-Source Leakage Current	$V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$	I_{GSS}	--	--	± 100	nA
Drain-Source Leakage Current	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}$	I_{DSS}	--	--	1	μA
	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}$ $T_J = 125^\circ\text{C}$		--	--	100	
Drain-Source On-State Resistance (Note 2)	$V_{GS} = 4.5\text{V}, I_D = 4\text{A}$	$R_{DS(on)}$	--	27	32	m Ω
	$V_{GS} = 2.5\text{V}, I_D = 4\text{A}$		--	32	40	
Forward Transconductance (Note 2)	$V_{DS} = 5\text{V}, I_D = 4\text{A}$	g_{fs}	--	9.5	--	S
Dynamic (Note 3)						
Total Gate Charge	$V_{GS} = 4.5\text{V}, V_{DS} = 15\text{V},$ $I_D = 4\text{A}$	Q_g	--	8.9	--	nC
Total Gate Charge	$V_{GS} = 2.5\text{V}, V_{DS} = 15\text{V},$ $I_D = 4\text{A}$	Q_g	--	5.1	--	
Gate-Source Charge		Q_{gs}	--	1.5	--	
Gate-Drain Charge		Q_{gd}	--	2	--	
Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 15\text{V}$ $f = 1.0\text{MHz}$	C_{iss}	--	792	--	pF
Output Capacitance		C_{oss}	--	53	--	
Reverse Transfer Capacitance		C_{rss}	--	21	--	
Gate Resistance	$f = 1.0\text{MHz}$	R_g	--	1	--	Ω
Switching (Note 3)						
Turn-On Delay Time	$V_{GS} = 10\text{V}, V_{DS} = 15\text{V},$ $I_D = 4\text{A}, R_G = 2\Omega,$	$t_{d(on)}$	--	5.8	--	ns
Turn-On Rise Time		t_r	--	32	--	
Turn-Off Delay Time		$t_{d(off)}$	--	19	--	
Turn-Off Fall Time		t_f	--	28	--	
Source-Drain Diode						
Forward Voltage (Note 2)	$V_{GS} = 0\text{V}, I_S = 4\text{A}$	V_{SD}	--	--	1	V
Reverse Recovery Time	$I_S = 4\text{A},$ $di/dt = 100\text{A}/\mu\text{s}$	t_{rr}	--	8	--	ns
Reverse Recovery Charge		Q_{rr}	--	3.3	--	nC

Notes:

1. Silicon limited current only.
2. Pulse test: Pulse Width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
3. Switching time is essentially independent of operating temperature.

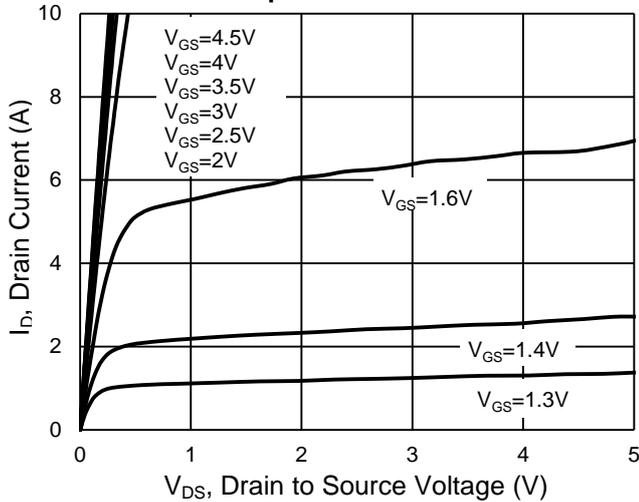
ORDERING INFORMATION

ORDERING CODE	PACKAGE	PACKING
TSM320N03CX RFG	SOT-23	3,000pcs / 7" Reel

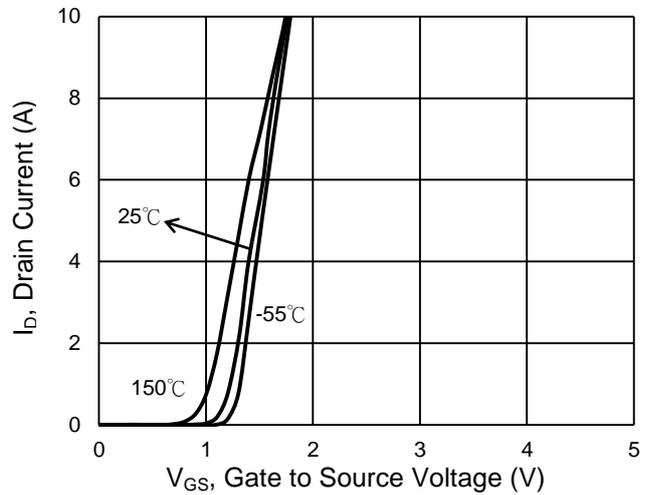
CHARACTERISTICS CURVES

($T_A = 25^\circ\text{C}$ unless otherwise noted)

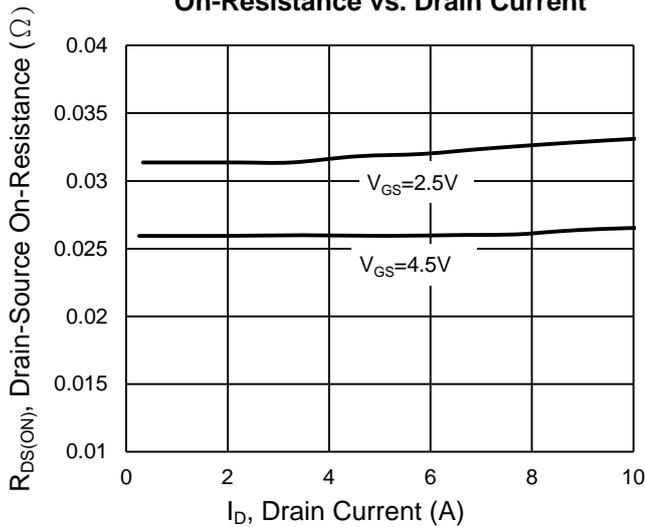
Output Characteristics



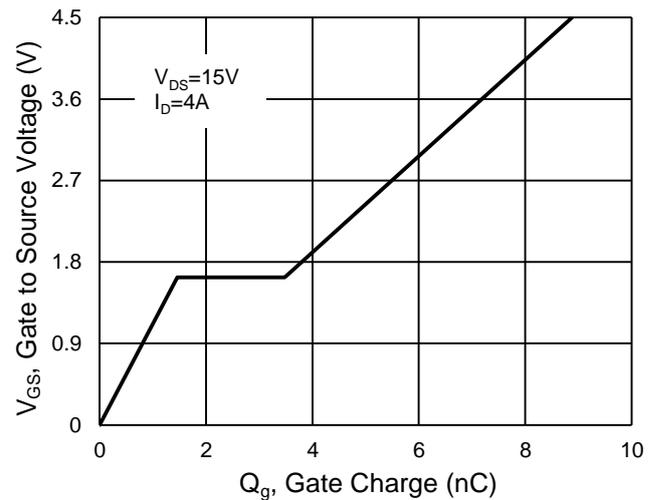
Transfer Characteristics



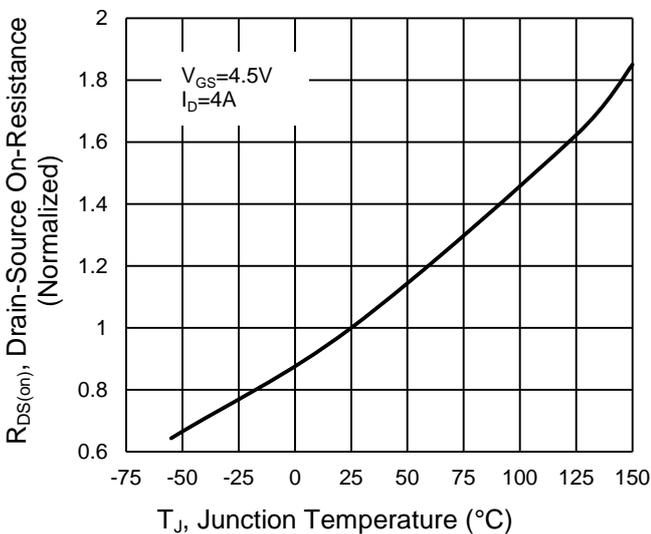
On-Resistance vs. Drain Current



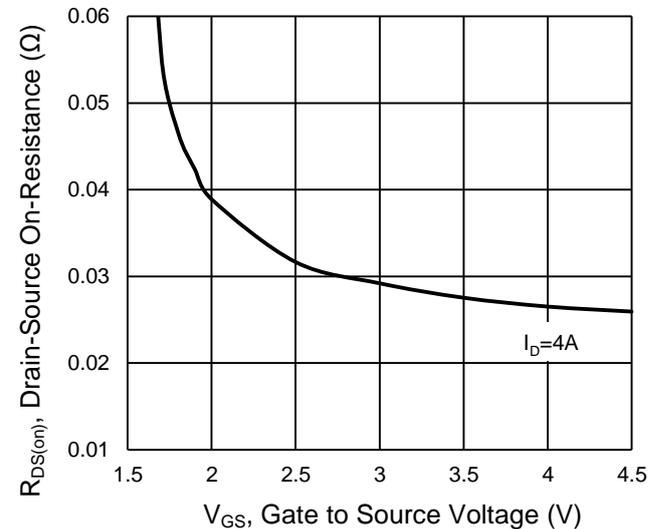
Gate-Source Voltage vs. Gate Charge



On-Resistance vs. Junction Temperature



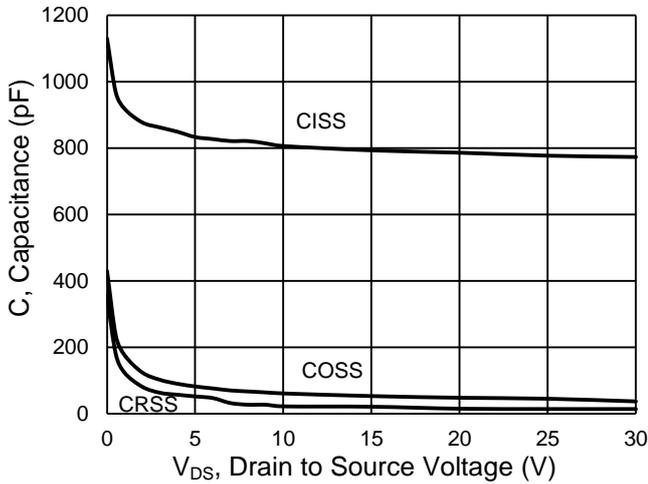
On-Resistance vs. Gate-Source Voltage



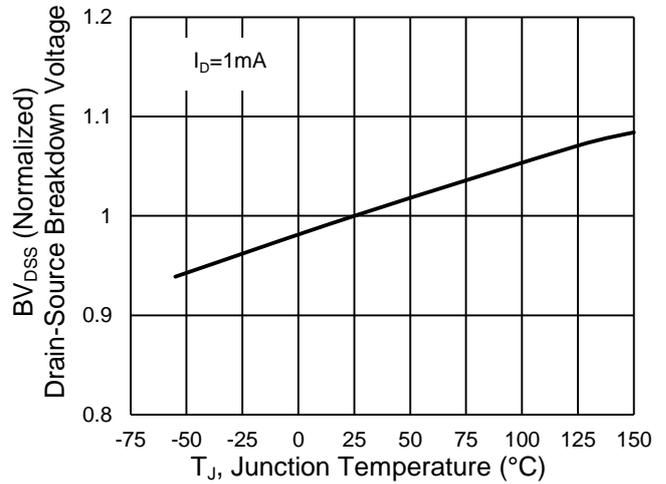
CHARACTERISTICS CURVES

($T_A = 25^\circ\text{C}$ unless otherwise noted)

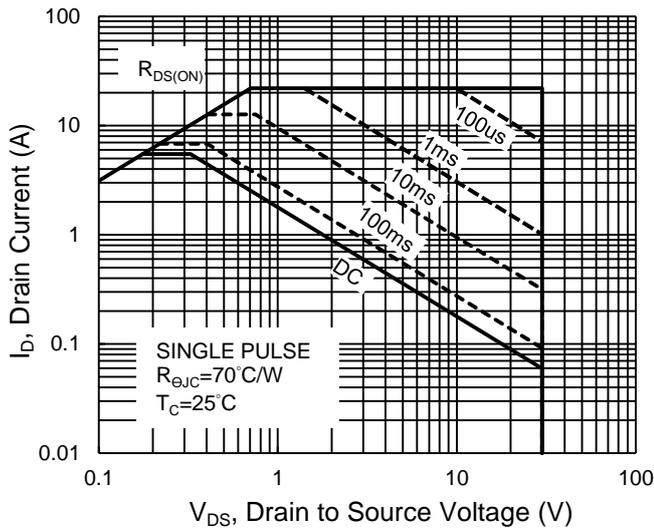
Capacitance vs. Drain-Source Voltage



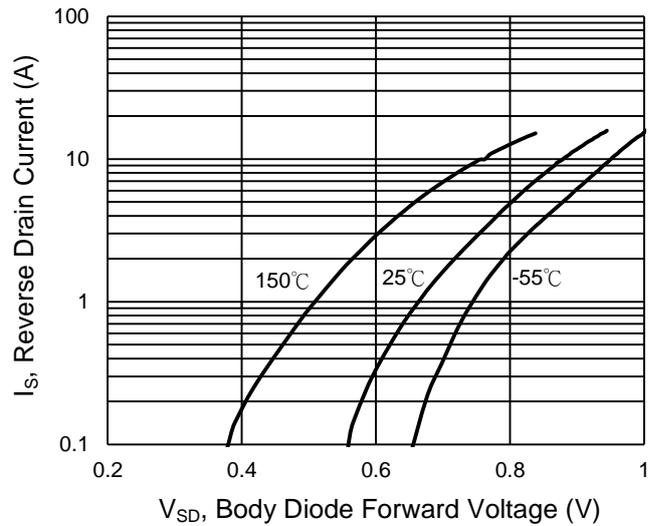
BV_{DSS} vs. Junction Temperature



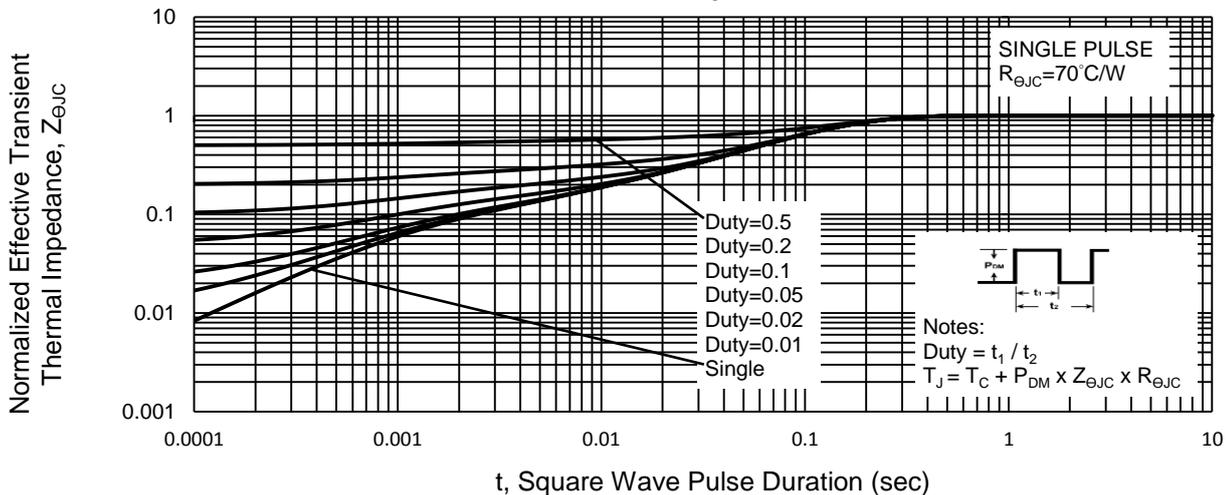
Maximum Safe Operating Area, Junction-to-Case



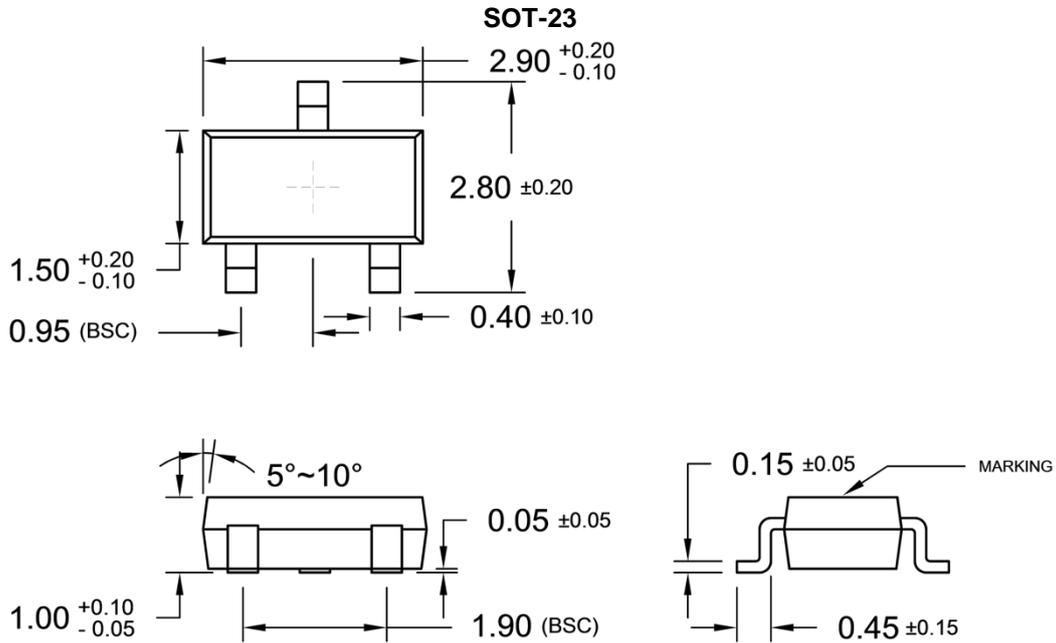
Source-Drain Diode Forward Current vs. Voltage



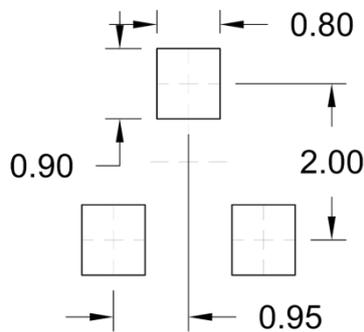
Normalized Thermal Transient Impedance, Junction-to-Case



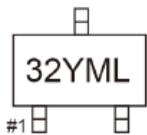
PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)



SUGGESTED PAD LAYOUT (Unit: Millimeters)



MARKING DIAGRAM



- 32** = Device Code
- Y** = Year Code
- M** = Month Code
- O** =Jan **P** =Feb **Q** =Mar **R** =Apr
- S** =May **T** =Jun **U** =Jul **V** =Aug
- W** =Sep **X** =Oct **Y** =Nov **Z** =Dec
- L** = Lot Code

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